

<b>Notice of References Cited</b>	Application/Control No. 10/730,664	Applicant(s)/Patent Under Reexamination BEICHTER ET AL.	
	Examiner Raj K. Jain	Art Unit 2616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,763,454	07-2004	Wilson et al.	713/1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	EP 0969371A1	05-2000	Europe	Siamak et al	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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